Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/731,617	LIAO, FANG-JWU	
Examiner	Art Unit	
Mathieu D. Vargot	1732	

	SEARCHED				
Class	Subclass	Date	Examiner		
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-	1.1,25, 85,1.34,				
	500	3/4/06	MIN		
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INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
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	DATE	EXMR
		
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